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ATTY DOCKET NO. 3308 CON

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE 4/3/13

| IN THE APPLICATION OF: | } |
|---|--------------------------------|
| BIN-SHING CHEN | Group Art Unit 2811 |
| SERIAL NO.: (Continuation of 09/769,576) |)) Examiner Thien F. Tran |
| FILED: |) Examiner Thien F. Itali) |
| FOR: METHOD FOR MANUFACTURING SPLIT-GATE EEPROM MEMORY CELL AND STRUCTURE FORMED THEREBY | TEO! |
| PRELIMINARY A | MENDMENT RECEIVOLOGY |
| The Honorable Commissioner of Patents and Trademarks Washington, D. C. 20231 | VED 2003 CENTER |
| Sir: | 2800 |

This application is a continuation application of prior application U.S. Serial No. 09/769,586

In the Claims:

Please cancel claims 1-10, amend Claim 11, and add new Claim 12 as follows:

11. (Once Amended) A structure of an Electrically Erasable Programmable Read-Only

Memory (EEPROM) comprising:

a silicon substrate having a source/drain region;

a tunnel oxide layer disposed over said silicone substrate;

a select gate disposed over said tunnel oxide layer, wherein said select gate is defined by a conductive layer covered with a first insulated material thereon and comprises a sidewall made of a second insulated material;

a sidewall forming a single floating gate aligned to one side of said select gate;

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